# AUIRF8736M2TR

Automotive DirectFET® Power MOSFET ②

- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density

International

**ICR** Rectifier

- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Allowed up to Tjmax
- Lead Free, RoHS Compliant and Halogen Free
- Automotive Qualified \*

V <sub>(BR)DSS</sub>	40V
R <sub>DS(on)</sub> typ.	1.3mΩ
max.	1.9mΩ
D (Silicon Limited)	137A
Q <sub>g</sub>	136nC
	DirectFET® ISOMETRIC

### Applicable DirectFET<sup>®</sup> Outline and Substrate Outline ①

SB	SC		M2	M4	L4	L6	L8	
<b>D</b> :								

#### Description

The AUIRF8736M2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging technology to achieve exceptional performance in a package that has the footprint of an SO-8 or 5X6mm PQFN and only 0.7mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF8736M2 to offer substantial system level savings and performance improvement specifically in motor drive, DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve ultra low on-resistance per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRF8736M2	DirectFET2 M-CAN	Tape and Reel	4800	AUIRF8736M2TR

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units	
V <sub>DS</sub>	Drain-to-Source Voltage	40	V	
V <sub>GS</sub>	Gate-to-Source Voltage	±20		
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ④	137		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ④	97	^	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V 3	27	A	
I <sub>DM</sub>	Pulsed Drain Current ©	565		
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation ④	63	147	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation 3	2.5	W	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ©	82	mJ	
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy 6	254		
I <sub>AR</sub>	Avalanche Current ©	See Fig. 14, 15, 22a, 22b	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy S			
T <sub>P</sub> Peak Soldering Temperature		270	mJ	
TJ	Operating Junction and	-55 to + 175	°C	
T <sub>STG</sub>	Storage Temperature Range		°C	

\*Qualification standards can be found at http://www.irf.com/

#### **Thermal Resistance**

Symbol	Parameter	Тур	).	Max.	Units
$R_{ ext{ heta}JA}$	Junction-to-Ambient 3		-	60	
$R_{ ext{ heta}JA}$	Junction-to-Ambient ®	12.5	5		
$R_{ ext{ heta}JA}$	Junction-to-Ambient				°C/W
$R_{ ext{ hetaJ-Can}}$	Junction-to-Can @		-	2.4	
R <sub>0J-PCB</sub>	Junction-to-PCB Mounted	1.0			
	Linear Derating Factor ④		0	.42	W/°C

## Static Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	40			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.03		V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		1.3	1.9	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 85A ⑦
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.2		3.9	V	$V_{DS} = V_{GS}, I_D = 150 \mu A$
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Coefficient		-9.3		mV/°C	
gfs	Forward Transconductance	150			S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 85A
R <sub>G</sub>	Internal Gate Resistance		0.73		Ω	
	Drain to Course Lookage Current			1.0		$V_{DS} = 40V, V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			150	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100		V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V

#### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

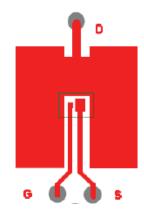
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		136	204		V <sub>DS</sub> = 20V
Q <sub>gs1</sub>	Gate-to-Source Charge		28			V <sub>GS</sub> = 10V
Q <sub>gs2</sub>	Gate-to-Source Charge		10		nC	I <sub>D</sub> = 85A
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		45			
Q <sub>godr</sub>	Gate Charge Overdrive		53			
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		55			
Q <sub>oss</sub>	Output Charge		41			$V_{DS} = 32V, V_{GS} = 0V$
t <sub>d(on)</sub>	Turn-On Delay Time		36			V <sub>DD</sub> = 40V, V <sub>GS</sub> = 10V ⑦
t <sub>r</sub>	Rise Time		119			I <sub>D</sub> = 85A
t <sub>d(off)</sub>	Turn-Off Delay Time		82		ns	$R_{G} = 6.8\Omega$
t <sub>f</sub>	Fall Time		83			
C <sub>iss</sub>	Input Capacitance		6867			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		1045			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		682		pF	f = 1.0 MHz
C <sub>oss</sub> eff.	Effective Output Capacitance		1362			$V_{GS}$ = 0V, $V_{DS}$ = 0V to 32V

2



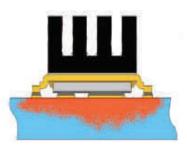
#### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			137	^	MOSFET symbol
I <sub>S</sub>	(Body Diode)				A	showing the
1	Pulsed Source Current			565	^	integral reverse 🛯 🖓 🛄 🚺
I <sub>SM</sub>	(Body Diode) <sup>⑤</sup>				A	p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$T_J$ = 25°C, $I_S$ = 85A, $V_{GS}$ = 0V $\odot$
t <sub>rr</sub>	Reverse Recovery Time		46		ns	I <sub>F</sub> = 85A, V <sub>DD</sub> = 25V
Q <sub>rr</sub>	Reverse Recovery Charge		59		nC	dv/dt = 100A/µs ⊘



③ Surface mounted on 1 in. square Cu board (still air).

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 Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air).



#### 1000 VGS 15V 10V TOP 8.0V 7.0V l<sub>D</sub>, Drain-to-Source Current (A) 100 6.0V 5.5V 5.0V 4.5V воттом 10 1 ≤60µs PULSE WIDTH Tj = 25°C 0.1 0.1 1 10 100 V<sub>DS</sub>, Drain-to-Source Voltage (V)

Fig. 1 Typical Output Characteristics

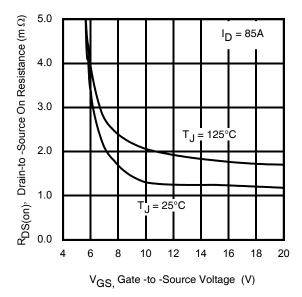


Fig. 3 Typical On-Resistance vs. Gate Voltage

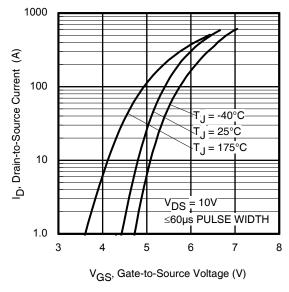
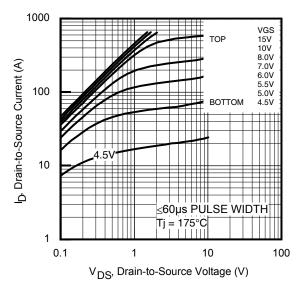
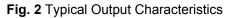


Fig 5. Transfer Characteristics





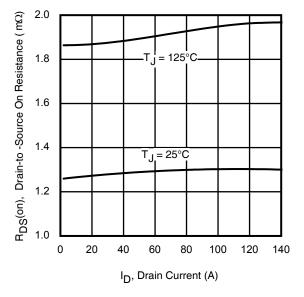


Fig. 4 Typical On-Resistance vs. Drain Current

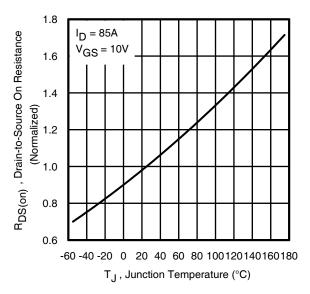


Fig 6. Normalized On-Resistance vs. Temperature



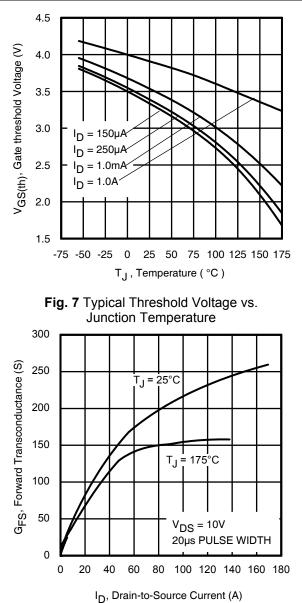


Fig 9. Typical Forward Transconductance vs. Drain Current

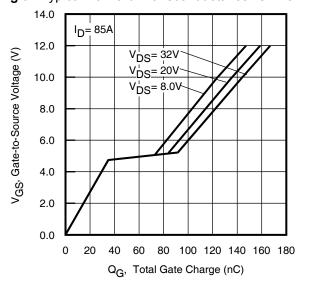
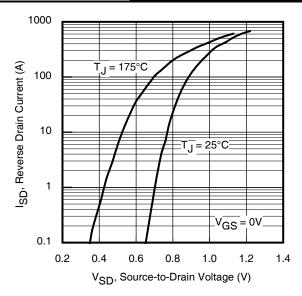
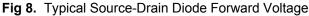
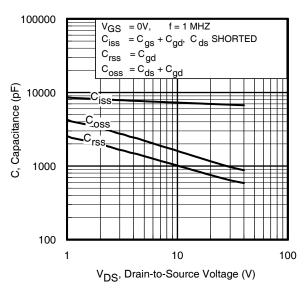


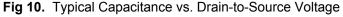
Fig 11. Typical Gate Charge vs. Gate-to-Source Voltage

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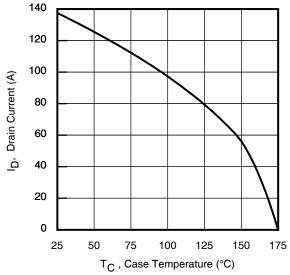
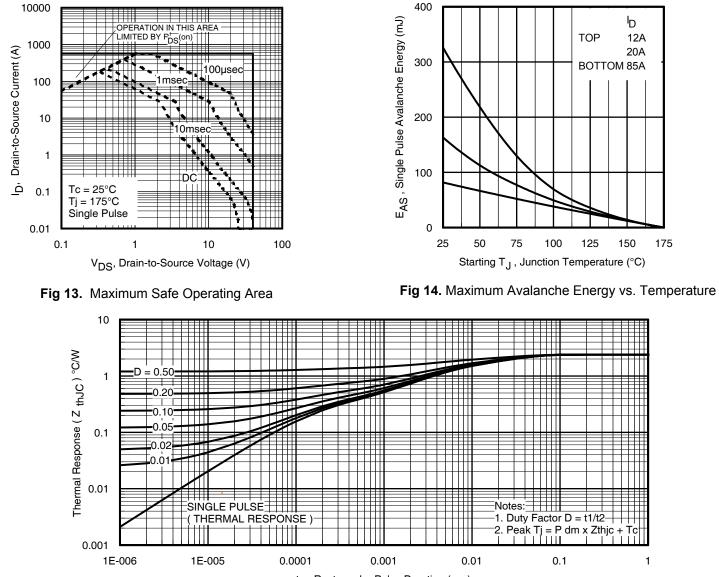


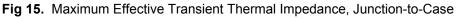
Fig 12. Maximum Drain Current vs. Case Temperature



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t<sub>1</sub> , Rectangular Pulse Duration (sec)



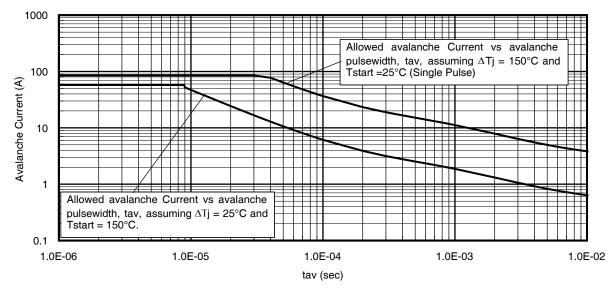
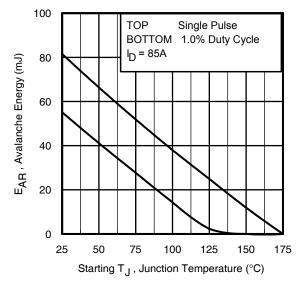
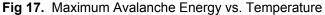


Fig 16. Single Avalanche Event: Pulse Current vs. Pulse Width







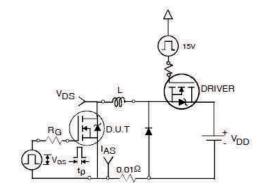


Fig 18a. Unclamped Inductive Test Circuit

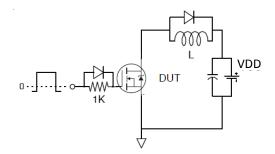


Fig 19a. Gate Charge Test Circuit

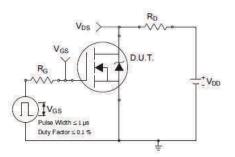


Fig 20a. Switching Time Test Circuit

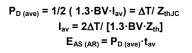
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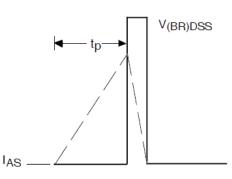
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#### Notes on Repetitive Avalanche Curves , Figures 16, 17: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 16, 17).
  - tav = Average time in avalanche.
  - D = Duty cycle in avalanche =  $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 15)





#### Fig 18b. Unclamped Inductive Waveforms

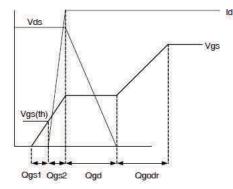


Fig 19b. Gate Charge Waveform

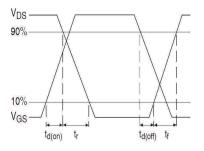
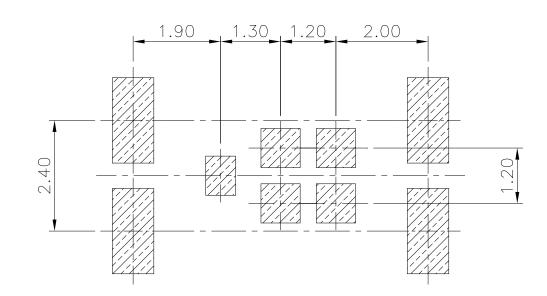


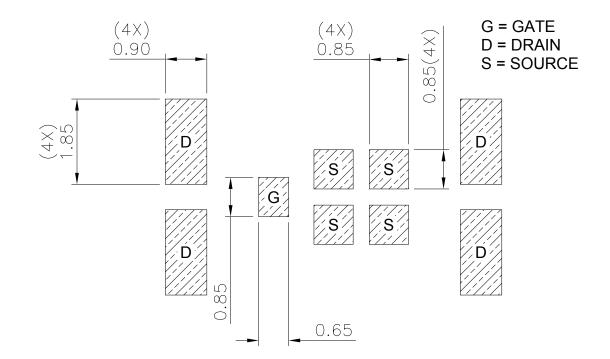
Fig 20b. Switching Time Waveforms



# DirectFET<sup>®</sup> Board Footprint, M4 Outline (Medium Size Can, 4-Source Pads)

Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET. This includes all recommendations for stencil and substrate designs.





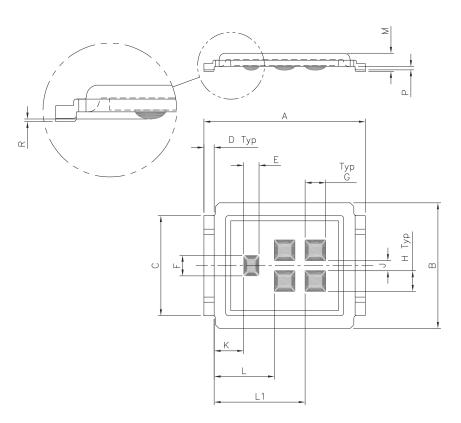
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

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# DirectFET<sup>®</sup> Outline Dimension, M4 Outline (Medium Size Can, 4-Source Pads)

Please see DirectFET application note AN-1035 for all details regarding the assembly of DirectFET. This includes all recommendations for stencil and substrate designs.

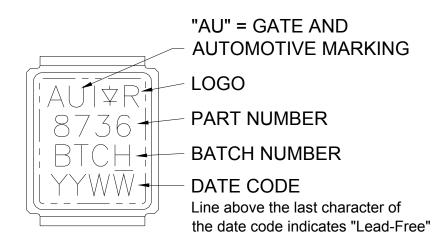


DIMENSIONS							
	MET	RIC	IMPE	RIAL			
CODE	MIN	MAX	MIN	MAX			
Α	6.25	6.35	0.246	0.250			
В	4.80	5.05	0.189	0.199			
С	3.85	3.95	0.152	0.156			
D	0.35	0.45	0.014	0.018			
E	0.58	0.62	0.023	0.024			
F	0.78	0.82	0.031	0.032			
G	0.78	0.82	0.031	0.032			
Н	0.78	0.82	0.031	0.032			
J	0.38	0.42	0.015	0.017			
К	1.10	1.20	0.043	0.047			
L	2.30	2.40	0.090	0.094			
L1	3.50	3.60	0.138	0.142			
М	0.68	0.74	0.027	0.029			
Р	0.09	0.17	0.003	0.007			
R	0.02	0.08	0.001	0.003			

Dimensions are shown in millimeters (inches)

## DirectFET<sup>®</sup> Part Marking

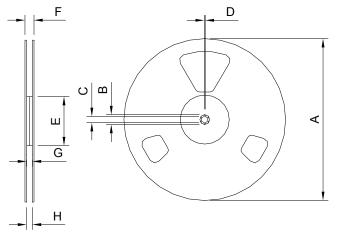
9



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



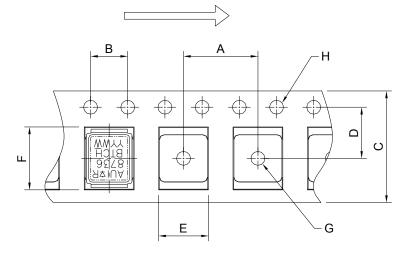
### DirectFET<sup>®</sup> Tape & Reel Dimension (Showing component orientation)



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts. (ordered as AUIRF8736M2TR). For 1000 parts on 7" reel, order AUIRF8736M2TR

		EL DIME		
S	TANDAR	D OPTIO	N (QTY 48	800)
	ME	ETRIC	IMP	ERIAL
CODE	MIN	MAX	MIN	MAX
A	330.0	N.C	12.992	N.C
В	20.2	N.C	0.795	N.C
C	12.8	13.2	0.504	0.520
D	1.5	N.C	0.059	N.C
E	100.0	N.C	3.937	N.C
F	N.C	18.4	N.C	0.724
G	12.4	14.4	0.488	0.567
H	11.9	15.4	0.469	0.606

#### LOADED TAPE FEED DIRECTION



	DIMENSIONS							
		METRIC		IMPERIAL				
NOTE: CONTROLLING DIMENSIONS IN MM	CODE	MIN	MAX	MIN	MAX			
	A	7.90	8.10	0.311	0.319			
	В	3.90	4.10	0.154	0.161			
	С	11.90	12.30	0.469	0.484			
	D	5.45	5.55	0.215	0.219			
	E	5.10	5.30	0.201	0.209			
	F	6.50	6.70	0.256	0.264			
	G	1.50	N.C	0.059	N.C			
	Н	1.50	1.60	0.059	0.063			

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

## Qualification Information<sup>†</sup>

			Automotive (per AEC-Q101)		
Qualification Level Comments: This part number(s) passed Automotive qualific Industrial and Consumer qualification level is granted by extendigher Automotive level.					
Moisture Se	ensitivity Level	Medium Can	MSL1		
	Machine Model		Class M4 (+/- 800V) <sup>††</sup>		
			AEC-Q101-002		
ESD	Human Body Model		Class H2 (+/- 4000V) <sup>††</sup>		
		AEC-Q101-001			
RoHS Compliant		Yes			

† Qualification standards can be found at International Rectifier's web site: <u>http://www.irf.com/</u>

†† Highest passing voltage.

- ① Click on this section to link to the appropriate technical paper.
- $\ensuremath{\textcircled{O}}$  Click on this section to link to the DirectFET  $\ensuremath{\textcircled{O}}$  Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④ T<sub>c</sub> measured with thermocouple mounted to top (Drain) of part.
- S Repetitive rating; pulse width limited by max. junction temperature.
- $\ensuremath{\textcircled{}^{\circ}}$  Starting  $T_{J}$  = 25°C, L = 0.023mH,  $R_{G}$  = 50 $\Omega,$   $I_{AS}$  = 85A, Vgs = 10V.
- $\oslash~$  Pulse width  $\leq 400 \mu s;~ duty~ cycle \leq 2\%.$
- Ised double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- @ R<sub> $\theta$ </sub> is measured at T<sub>J</sub> of approximately 90°C.

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http://www.irf.com/technical-info/

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Tel: (310) 252-7105